


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522618	<b>Applicant(s)/Patent Under Reexamination</b>  KAMEYAMA ET AL.
	<b>Examiner</b>  Empie, Nathan H	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
427	307	10/30/07	NHE

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	10/30/07	NHE
EAST search report included	10/29-30/07	NHE
Search updated	4/29/08	NHE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner